

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination
		09/901,402	HSIEH ET AL.
Examiner		Art Unit	
Ricardo Pizarro		2661	

ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
370	351	705	24 37
INTERNATIONAL CLASSIFICATION		570	400
H04L 12/28			
/			
/			
/			
/			
Ricardo Pizarro (Assistant Examiner) 1/21/06		 HASSAN KIZOU SUPERVISORY PATENT EXAMINER (Primary Examiner) CENTER 2000	
Joyce D. Gibbs (Legal Instruments Examiner) 1/24/06		Total Claims Allowed: 19 O.G. Print Claim(s) / O.G. Print Fig. /	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	16	31	61	91	121	151
2	2	17	32	62	92	122	152
3	3	18	33	63	93	123	153
4	4	19	34	64	94	124	154
5	5	20	35	65	95	125	155
6	6	21	36	66	96	126	156
7	7	22	37	67	97	127	157
8	8	23	38	68	98	128	158
9	9	24	39	69	99	129	159
10	10	25	40	70	100	130	160
11	11	26	41	71	101	131	161
12	12	27	42	72	102	132	162
13	13	28	43	73	103	133	163
14	14	29	44	74	104	134	164
15	15	30	45	75	105	135	165
16	16	31	46	76	106	136	166
17	17	32	47	77	107	137	167
18	18	33	48	78	108	138	168
19	19	34	49	79	109	139	169
20	20	35	50	80	110	140	170
21	21	36	51	81	111	141	171
22	22	37	52	82	112	142	172
23	23	38	53	83	113	143	173
24	24	39	54	84	114	144	174
25	25	40	55	85	115	145	175
26	26	41	56	86	116	146	176
27	27	42	57	87	117	147	177
28	28	43	58	88	118	148	178
29	29	44	59	89	119	149	179
30	30	45	60	90	120	150	180